Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/066,582	HOFFMANN, JURGEN
Examiner	Art Unit
Thanh X. Luu	2878

	SEAR	CHED		1
Class	Subclass	D	ate	Examiner
250	234, 201.1- 201.3, 216, 306,307	es 1	os	ML
250	458.1			
250	459.1			
250	461.1			
250	461.2		\overline{I}	1/1
359	368,385	W		V

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
Same as	above	05/05	TXC	-	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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